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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

First Named Inventor : Amit Dinesh Sanghani
Application No. : 09/996,866
Filed : November 27, 2001
Docket : SUN-P5759
Title : Built-In Self-Testing for Double Data Rate Input/Output

Group/Art Unit : 2133
Examiner : David Ton

REPLY UNDER 37 C.F.R. § 1.111

RECEIVED

MAY 13 2004

Commissioner for Patents
Alexandria, VA 22313

Technology Center 2100

Sir:

In response to the Office Action mailed February 24, 2004, please amend the subject application as follows and consider the corresponding Remarks.

05/10/2004 STEUHEL1 00000020 09996866

01 FC:1202 54.00 OP
02 FC:1201 86.00 OP